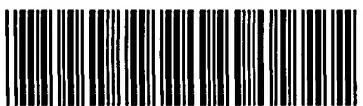


<b>Search Notes</b>	Application/Control No.  10776527	Applicant(s)/Patent Under Reexamination  CHEN, CHIH-WEI
	Examiner  Keefer, Michael E	Art Unit  2154

### SEARCHED

Class	Subclass	Date	Examiner
709	220	8/14/2007	MEK

### SEARCH NOTES

Search Notes	Date	Examiner
EAST Search	8/14/2007	MEK
Consulted Examiner Dustin Nguyen	8/13/2007	MEK
Google Search	8/14/2007	MEK
709/220-222 keyword limited	8/14/2007	MEK

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner